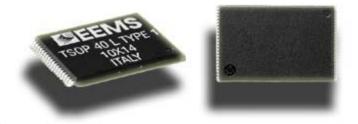
TSOP I

Thin Small Outline Package Type I

EEMS offers TSOP I packages to the designers who require a package that is small and thin with end leads.

With a 1.0mm thick body, this package has the short lead lengths for die designs where speed is important: it is available in different body sizes and pin count.

The packages are automatically fully inspected to insure flatness and coplanarity.



Features & Benefits

- Small board area needed
- Small size
- Cost competitive
- High reliability
- Compliant to Rohs directive 2002/95/CE



Copper Substrate MATRIX Leadframe

Applications

Memory, memory and memory are the primary users of this package.

Device

- SDRAM
- NAND FLASH
- E² PROM
- ASIC's

End Equipment

- Telecom Systems
- Memory Cards
- USB Stickers
- Wireless Base System
- Data Media
- PC Peripherals

Process Highlights

Processable wafer Die Tickness Bond Pad Pitch Marking Lead inspection 200 – 300 mm 0.280 mm max 60 um min Laser Auto inspection



Standard Materials

| Substrate |
|---------------------|
| Die Attach |
| Gold wire |
| Mold Compound |
| Lead Solder Plating |
| Packing |
| Packing option |
| |

AL42/Copper Leadframe Low stress mtl 25-30 um Epoxy 85/15 Sn/Pb or 100% Sn Jedec Tray/Tape & Reel Dry Pack

TSOP I

Specifications

Electrical (simulated w/bondwire)

(12 x 18.4 x 1.0 mm body with 48 leads)

| Capacitance (pF) | : 0.5 - 0.9 at 1 GHz |
|--------------------------|------------------------|
| Inductance (nH) | : 3.2 - 4.3 at 1 GHz |
| Resistance (m Ω) | : 200 - 260 at 100 Mhz |

Reliability

| Moisture Sensitivity | : | JEDEC MSL 3 @ up to 260 °C, |
|----------------------|---|-------------------------------|
| High Temp Storage | : | 150 °C, 1000 hours |
| Temp Cycle | : | -65/+150 °C, 1000 cicles |
| Temp Humidity Test | : | 130 °C/85% RH, 240 hours HAST |
| PCT | : | 121 °C/2 atm., 240 hours |

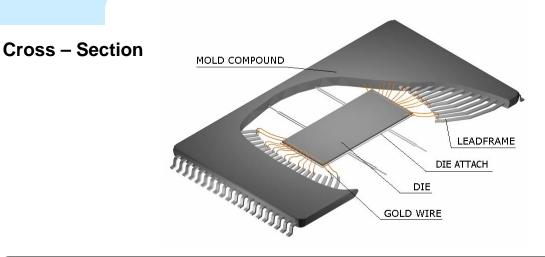
Thermal Resistance (simulated)

(12 x 18.4 x 1.0 mm with 48 leads; 1 Watt, 0 m/s airflow as per JEDEC JESD51.2):

 Θ ja = 39 °C/watt Typical

Available Services

- 300 mm wafer full processing
- Wafer backgrinding
- Wafer map / sort
- Product Engineering
- -30 + 125 °C full test
- Dynamic Burn In
- Compliant to Rohs directive 2002/95/CE



| TSOP I Nominal Package Dimensions (mm) | | | | | | | | |
|--|------------|------------|-------------------|-------------------|-----------|-------------------|--------|--|
| Body Area | Lead Count | Lead Pitch | Lead edge to edge | Body Thickness | Stand-off | Overall Height | JEDEC | |
| 10.0 x 12.4 | 40 | 0.50 | 14.0 | 1.00 | 0.10 | 1.2 max | MO-142 | |
| 8.0 x 18.4 | 32 | 0.50 | 20.0 | 1.00 | 0.10 | 1.2 max | MO-122 | |
| 10.0 x 18.4 | 40 | 0.50 | 20.0 | 1.00 | 0.10 | 1.2 max | MO-122 | |
| 12.0 x 18.4 | 48 | 0.50 | 20.0 | 1.00 | 0.10 | 1.2 max | MO-142 | |

